

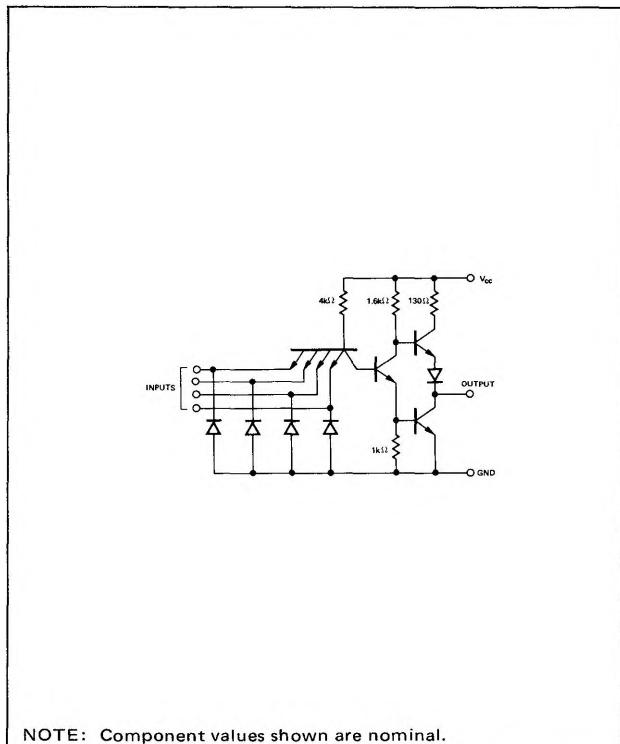
DUAL 4-INPUT POSITIVE NAND GATE

**S5420
N7420**

S5420-A,F,W • N7420-A,F

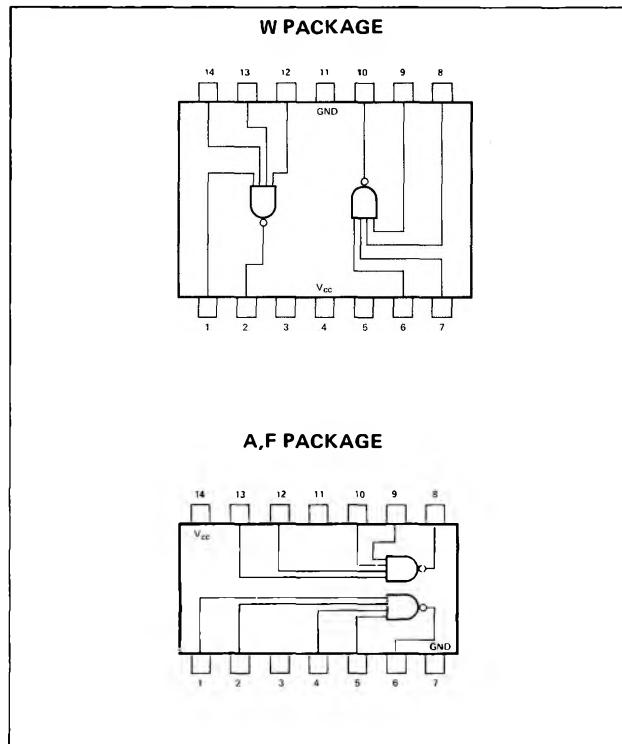
DIGITAL 54/74 TTL SERIES

SCHEMATIC (each gate)



NOTE: Component values shown are nominal.

PIN CONFIGURATIONS



RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
Supply Voltage V_{CC} :	S5420 Circuits	4.5	5	5.5	V
	N7420 Circuits	4.75	5	5.25	V
Normalized Fan-Out from Output, N				10	
Operating Free-Air Temperature Range, T_A :	S5420 Circuits	-55	25	125	°C
	N7420 Circuits	0	25	70	°C

ELECTRICAL CHARACTERISTICS (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	MIN	TYP**	MAX	UNIT
$V_{in(1)}$	$V_{CC} = \text{MIN}$	2			V
$V_{in(0)}$	$V_{CC} = \text{MIN}$			0.8	V
$V_{out(1)}$	$V_{CC} = \text{MIN}, I_{load} = -400\mu\text{A}$	2.4	3.3		V
$V_{out(0)}$	$V_{CC} = \text{MIN}, I_{sink} = 16\text{mA}$		0.22	0.4	V
$I_{in(0)}$	$V_{CC} = \text{MAX}, V_{in} = 0.4\text{V}$			-1.6	mA
$I_{in(1)}$	$V_{CC} = \text{MAX}, V_{in} = 2.4\text{V}$ $V_{CC} = \text{MAX}, V_{in} = 5.5\text{V}$			40 1	μA mA
I_{OS}	$V_{CC} = \text{MAX},$ S5420 N7420	-20 -18		-55 -55	mA

SIGNETICS DIGITAL 54/74 TTL SERIES - S5420 • N7420

ELECTRICAL CHARACTERISTICS (Cont'd)

PARAMETER	TEST CONDITIONS*	MIN	TYP**	MAX	UNIT
I _{CC(0)} Logical 0 level supply current	V _{CC} = MAX, V _{in} = 5V		6	11	mA
I _{CC(1)} Logical 1 level supply current	V _{CC} = MAX, V _{in} = 0		2	4	mA

SWITCHING CHARACTERISTICS, V_{CC} = 5V, T_A = 25°C, N = 10

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{pd0} Propagation delay time to logical 0 level	C _L = 15pF, R _L = 400Ω		8	15	ns
t _{pd1} Propagation delay time to logical 1 level	C _L = 15pF, R _L = 400Ω		12	22	ns

* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

** All typical values are at V_{CC} = 5V, T_A = 25°C.

† Not more than one output should be shorted at a time.